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APPLICATION NO.	APPLICATION NO. FILING DATE		FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/046,741	10/046,741 01/17/2002		Yoshinobu Ono	3885-0103P	2546
2292	7590	12/20/2002			
BIRCH ST	EWART	KOLASCH & B	EXAMINER		
PO BOX 74				MULPURI, SAVITRI	
FALLS CHU	JRCH, VA	22040-0747			
				ART UNIT	PAPER NUMBER
				2812	C
				DATE MAILED: 12/20/2002	8

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No. 10/046,741 Applicant(s)

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Ono et al

Examiner

Savitri Mulpuri

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1	The MAILING DATE of this communication appears	on the cover sheet with the correspondence address
	for Reply	
	ORTENED STATUTORY PERIOD FOR REPLY IS SET	TO EXPIRE3 MONTH(S) FROM
	MAILING DATE OF THIS COMMUNICATION. isions of time may be available under the provisions of 37 CFR 1.136 (a). In	no event, however, may a reply be timely filed after SIX (6) MONTHS from the
mailing	date of this communication.	
- If NO		and will expire SIX (6) MONTHS from the mailing date of this communication.
	to reply within the set or extended period for reply will, by statute, cause the ply received by the Office later than three months after the mailing date of t	• • • • • • • • • • • • • • • • • • • •
_	patent term adjustment. See 37 CFR 1.704(b).	
Status 1)	Responsive to communication(s) filed on Jan 7, 20	02
2a) □	This action is FINAL . 2b) 💢 This act	
3) 🗌	Since this application is in condition for allowance	except for formal matters, prosecution as to the merits is
0, =	closed in accordance with the practice under Ex par	·
Disposi	tion of Claims	
4) 💢	Claim(s) <u>1-6</u>	is/are pending in the application.
4	la) Of the above, claim(s)	is/are withdrawn from consideration.
5) 🗆	Claim(s)	is/are allowed.
6) 💢	Claim(s) 1-6	is/are rejected.
	Claim(s)	
8) 🗆	Claims	are subject to restriction and/or election requirement.
Applica	ition Papers	
9) 🗆	The specification is objected to by the Examiner.	
10)💢	The drawing(s) filed on is/are	a) 💢 accepted or b) 🗆 objected to by the Examiner.
	Applicant may not request that any objection to the d	rawing(s) be held in abeyance. See 37 CFR 1.85(a).
11)	The proposed drawing correction filed on	is: a) \square approved b) \square disapproved by the Examiner.
	If approved, corrected drawings are required in reply to	
12)	The oath or declaration is objected to by the Exami	ner.
Priority	under 35 U.S.C. §§ 119 and 120	
13)💢	Acknowledgement is made of a claim for foreign pa	riority under 35 U.S.C. § 119(a)-(d) or (f).
a) 🕽	√ All b) □ Some* c) □ None of:	
	1. 💢 Certified copies of the priority documents hav	e been received.
	2. \square Certified copies of the priority documents hav	e been received in Application No
	3. Copies of the certified copies of the priority de application from the International Bure.	
*S	ee the attached detailed Office action for a list of the	e certified copies not received.
14)	Acknowledgement is made of a claim for domestic	priority under 35 U.S.C. § 119(e).
a) [The translation of the foreign language provisiona	al application has been received.
15)	Acknowledgement is made of a claim for domestic	priority under 35 U.S.C. §§ 120 and/or 121.
Attachm		
	tice of References Cited (PTO-892)	4) Interview Summary (PTO-413) Paper No(s).
	tice of Draftsperson's Patent Drawing Review (PTO-948)	5) Notice of Informal Patent Application (PTO-152)
3) [X] Inf	ormation Disclosure Statement(s) (PTO-1449) Paper No(s).	6) Uother:

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DETAILED ACTION

Claim Rejections - 35 USC § 103 The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-4 are rejected under 35 U.S.C. 103(a) as being unpatentable over Admitted prior art in combination with Narui.

Admitted prior teach a method of making a semiconductor device: providing a GaAs substrate growing buffer GaAs layer on GaAs, successively growing Algas with Al content of 0.4, Algas with Al content of .15 and Algas with Al content of 0.4(see fig. 3). Admitted prior art does not teach growing Algas with higher Al content with low growth rate to reduce defects.

Narui teaches successively growing GaAs layer on GaAs substrate; growing plurality of AlGaAs layers AlGaAs with Al content 0.45, algas with Al content 0.14, Algas with Al content 0.45, Algas with Al content 0.45 and Algas with Al content 0.45, wherein AlGaAs greater than 0.4 is grown at lower growth rate 0.16 nm/sec to roughness and in turn reduce the defects due to roughness (see abstract and fig. 6 and see the whole document). It would have been obvious to one of ordinary skill in the art to grow Algas layers in the admitted prior art at lower growth rate 0.16 nm/sec to obtain smooth surface on AlGaAs layers.

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(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-6 are rejected under 35 U.S.C. 102(b) as being anticipated by Narui.

Narui teaches successively growing GaAs layer on GaAs substrate; growing plurality of AlGaAs layers AlGaAs with Al content 0.45, algas with Al content 0.14, Algas with Al content 0.45, Algas with Al content 0.45 and Algas with Al content 0.45, wherein AlGaAs greater than 0.4 is grown at lower growth rate 0.16 nm/sec to roughness and in turn reduce the roughness (see abstract and fig. 6 and see the whole document). AlGaAs layer 1 and 2 as first set of buffer layer and AlGaAs 3-5 are second set of buffer layers, where in Al content in bottom layer of second set of buffer layers is higher than al content in top buffer layer of first set buffer layer.

The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to S. Mulpuri whose telephone number is 703-305-5184. The fax phone number for the organization where this application or proceeding is assigned is 703-308-7722.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is 703-308-0956.

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SAVITRI MULPURI